## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10523762	HASHIGUCHI, NAOKI	
Examiner	Art Unit	
Kruer, Stefan	3654	

SEARCHED					
Class	Subclass	Date	Examiner		
187	254, 258,286,373	09/07/2006	SHK		
254	290,316,901				
310	62,63,261				
Above		03/06/2007	SHK		
Updated					
H02K.ipc.	7/102	03/06/2007			
B66B.ipc.	11/08, 15/08	03/06/2007			

SEARCH NOTES					
Search Notes	Date	Examiner			
PLUS (not reviewed)	09/13/2006	SHK			
Consultations iwth Karl Tamai, AU 2834	09/07/2006	SHK			
PLUS	03/07/2007	SHK			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		
US PGPUBS		06/20/2007	SHK		

U.S. Patent and Trademark Office Part of Paper No.: 20070620